

# 47 CFR PART 15 SUBPART B

# **TEST REPORT**

of

### CDMA 1X Digital mobile phone

Model Name:

AV100

Brand Name:

AV100

Report No.:

SH08070003E01

FCC ID:

VR2AV100

prepared for

### Cal-Comp Electronics (Su Zhou) Co., Ltd.

No. 2288, Jiang Xing East Rd.,

Wu Jiang Economic Develop Star One, Jiang Su, China.

prepared by

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MORLA

Equipment under Test: CDMA1X Digital mobile phone

Brand Name: AV100 Model Name: AV100

FCC ID: VR2AV100

Applicant: Cal-Comp Electronics (Su Zhou) Co., Ltd.

No. 2288, Jiang Xing East Rd., Wu Jiang Economic Development

Zone, Jiang Su, China.

Manufacturer: Cal-Comp Electronics (Su Zhou) Co., Ltd.

No. 2288, Jiang Xing East Rd., Wu Jiang Economic Development

Zone, Jiang Su, China.

Test Standards: 47 CFR Part 15 Subpart B

Test Date(s): July 11, 2008 - July 11, 2008

Test Result: PASS

### \* We Hereby Certify That:

The equipment under test was tested by Shenzhen Electronic Product Quality Testing Center Morlab Laboratory. The test data, data evaluation, test procedures and equipment configurations shown in this report were made in accordance with the requirement of related FCC rules.

The test results of this report only apply for the tested sample equipment identified above. The test report shall be invalid without all the signatures of the test engineer, the reviewer and the approver.

Tested by:

Lou Qinchao Lou Qinchao

Dated: 2008.07.28

Reviewed by:

Thang lun

2008, 07, 28

Approved by:

Su Feng

200 6.0 /. LY



### 2 GENERAL INFORMATION

# 2.1 EUT Description

EUT Type...... CDMA1X Digital mobile phone

Model Name .....: AV100 Serial No.....: (n.a)

IMEI ..... 000000000000000

Brand name: EDAN Technology Co.,Ltd.

Mode no.: GCC37086008

Capacitance: 860mAh Rated voltage: 3.7V Charge limited: 4.2V

Manufacturer: EDAN Technology Co.,Ltd.

Manufacturer Address: No. 2288, Jiang Xing East Rd., Wu Jiang

Economic Development Zone, Jiang Su, China.

Ancillary Equipment 1 ..........: AC Adapter (Charger for Battery)

Model Name: TL0520550D-08

Brand Name: Shen-Zhen Tailing Technology Co.,Ltd.

Serial No.: (n.a. marked #1 by test site)
Rated Input: ~ 110/220V,50/60Hz

Rated Output: = 5.5 + /-0.3 V, 650 + /-100 mA

Manufacturer: Shen-Zhen Tailing Technology Co.,Ltd.

Wire Length: (n.a)

Note 1: The EUT is a model of CDMA1X morbile station operating in CDMA 800MHz band and CDMA PCS, CDMA 800MHz are tested in this report.

Note 2: The normal configuration for the EUT is the Mobile Phone (MS) associated with ancillary equipments e.g.theBattery and/or the AC Adapter(Charger).

Note 3: For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.



# 2.2 Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title
1	47 CFR Part 15	Radio Frequency Devices
	(10-1-05 Edition)	

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Result
1	15.107	Conducted Emission	PASS
2	15.109	Radiated Emission	PASS



### 2.3 Facilities and Accreditations

### 2.3.1 Facilities

Shenzhen Electronic Product Quality Testing Center Morlab Laboratory is a testing organization accredited by China National Accreditation Service for Laboratories (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L1659.

All measurement facilities used to collect the measurement data are located at Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen 518055 CHINA. The test site is constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22; the FCC registration number is 741109.

### 2.3.2 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	20 – 25
Relative Humidity (%):	40 - 60
Atmospheric Pressure (kPa):	960



# 3 TEST CONDITIONS SETTING

# 3.1 Test Mode

- 1. The test modes of the EUT are showed as below:
  - (1) Call mode

The EUT configuration of the emission tests is  $\underline{EUT + Battery + Charger}$ .

During the measurement, the lithium battery was installed into the EUT, and the charger was connected to the EUT.A communication link was established between the EUT and a System Simulator (SS).

(2) Idle mode

The EUT configuration of the emission tests is <u>EUT + Battery + Charger</u>.

Before the measurement, the lithium battery was completely discharge.

The EUT was registered to the base station simulator but no call was set up.

### NOTE:

All test modes are performed, only the worst cases are recorded in this report.

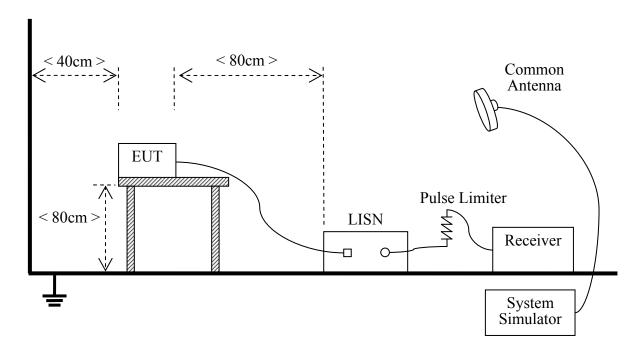




# 3.2 Test Setup and Equipments List

### 3.2.1 Conducted Emission

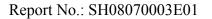
### A. Test Setup:



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides  $50\Omega/50\mu H$  of coupling impedance for the measuring instrument. The Common Antenna is used for the call between the EUT and the System Simulator (SS). A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

### **B.** Equipments List:

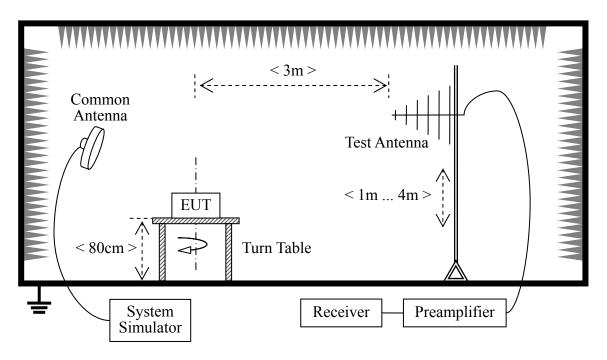
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due
Receiver	Rohde&Sch	ESCI3	100666	2007.11	1year
	warz				
LISN	Rohde&Sch	ENV216	812744	2007.11	1year
	warz				
System Simulator	Rohde&Sch	CMU200	105571	2007.12.	1year
	warz				
Personal Computer	Lenovo	(n.a.)	(n.a.)	(n.a.)	(n.a.)





### 3.2.2 Radiated Emission

# C. Test Setup:



The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower. The Common Antenna is used for the call between the EUT and the System Simulator (SS).

### **D.** Equipments List:

Description	Manufacturer	Model	Serial No.	Cal.	Cal. Due
				Date	
Receiver	Rohde&Sch	ESCI3	100666	2007.11	1 year
	warz				
Full-Anechoic	Albatross	9m*6m*6m	(n.a.)	2007.11	1 year
Chamber					
Test Antenna - Bi-Log	Rohde&Sch	HL562	100385	2007.11	1 year
	warz				
System Simulator	Rohde&Sch	CMU200	105571	2007.12	1 year
	warz				
Personal Computer	Lenovo	(n.a.)	(n.a.)	(n.a.)	(n.a.)



# **47 CFR PART 15B REQUIREMENTS**

### 4 Conducted Emission

### 4.1 Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a  $50\mu\text{H}/50\Omega$  line impedance stabilization network (LISN).

Eraguanay ranga (MHz)	Conducted L	imit (dBμV)
Frequency range (MHz)	Quai-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
0.50 - 30	60	50

### NOTE:

- a) The limit subjects to the Class B digital device.
- b) The lower limit shall apply at the band edges.
- c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 0.50MHz.

### **4.2 Test Description**

See section 3.2.1 of this report.

### 4.3 Test Result

The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

### 4.3.1.1 CDMA Test Mode

#### **4.3.1.1.1** The test mode

The EUT configuration of the emission tests is <u>EUT + Battery + Charger</u>.

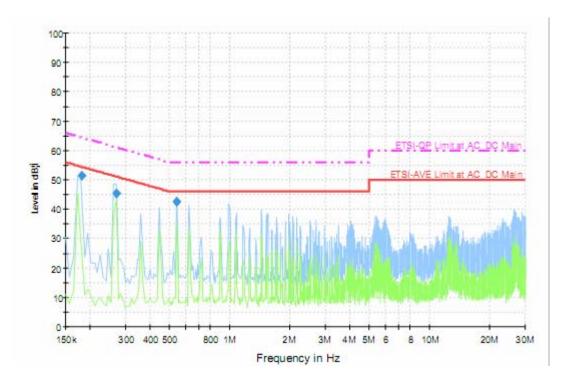
### A. Test Verdict Recorded for Suspicious Points:





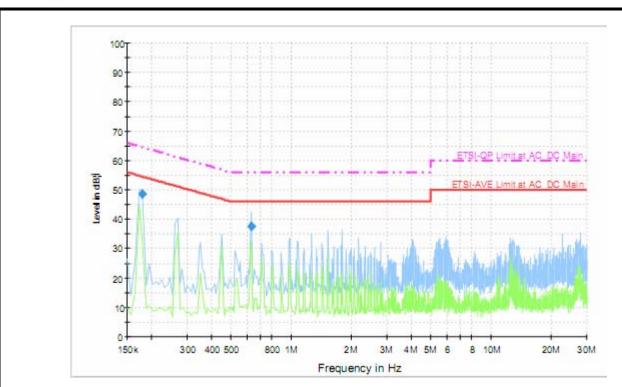
No.	@Frequency	Measi	Measured Emission Level (dBμV)				Limit (dBµV)	
NO.	(MHz)	PK	QP	AV	Phase	QP	AV	Verdict
1	0.180239	53.5	51.4	42.8	L	56.0	46.0	PASS
2	0.269242	47.2	45.4	42.0	L	56.0	46.0	PASS
3	0.539670	44.2	42.7	36.0	L	56.0	46.0	PASS
4	0.178630	50.0	48.5	43.5	N	56.0	46.0	PASS
5	0.631155	42.7	37.5	32.0	N	56.0	46.0	PASS

# **B.** Test Plot:



(Plot A: L Phase)





(Plot B: N Phase)



### 5 Radiated Emission

### 5.1 Requirement

According to FCC section 15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Fraguenay ranga (MHz)	Field Strength			
Frequency range (MHz)	μV/m	dBμV/m		
30 - 88	100	40		
88 - 216	150	43.5		
216 - 960	200	46		
Above 960	500	54		

### NOTE:

- a) Field Strength  $(dB\mu V/m) = 20*log[Field Strength (\mu V/m)].$
- b) In the emission tables above, the tighter limit applies at the band edges.

# **5.2** Test Description

See section 0 of this report.

### 5.3 Test Result

The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

#### 5.3.1.1 CDMA test mode

#### **5.3.1.1.1** The test mode

The EUT configuration of the emission tests is <u>EUT + Battery + Charger</u>.

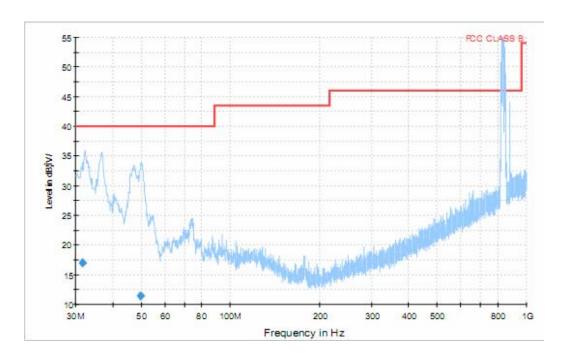
#### A. Test Plot:

Note: Following is the plots for emission measurement; please note that marked spikes with circle should be ignored because they are MS and SS carrier frequency.

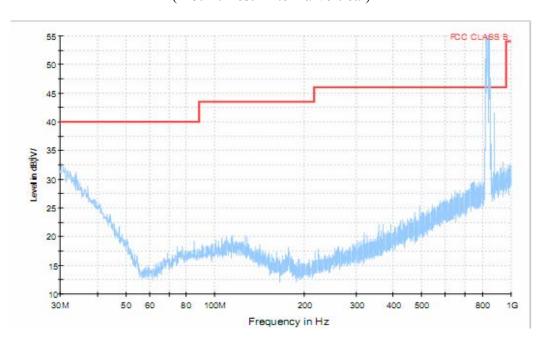




No.	@Frequency	Measured	Emission Level (dB)	Limit (dDV)	<b>V</b> / <b>1</b> : -4	
	(MHz)	PK	QP	Polarity	Limit (dBµV)	Verdict
1	33.4	33.5	17.4	V	40	PASS
2	50.1	36.1	12.3	V	40	PASS



(Plot A: Test Antenna Vertical)



(Plot B: Test Antenna Horizontal)

# \*\* END OF REPORT \*\*